

Notice of References Cited		Application/Control No. 10/766,591	Applicant(s)/Patent Under Reexamination CHEN ET AL.	
		Examiner Chrystina Zelaskiewicz	Art Unit 4143	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0050114	03-2003	Leen et al.	463/25
*	B	US-6,758,754	07-2004	Lavanchy et al.	463/42
*	C	US-7,086,947	08-2006	Walker et al.	463/25
*	D	US-7,367,888	05-2008	Chen et al.	463/42
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.